Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/082,450	JIAN ZHU ET AL
Examiner	Art Unit

Habte Mered

2662

SEARCHED					
Class	Subclass	Date	Examiner		
370	386-388	9/23/2006	НМ		
370	392	9/23/2006	НМ		
370	299	9/23/2006	НМ		
370	422	9/23/2006	НМ		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Searched EAST DB:USPG-PUB, USPAT, JPO and EPO	9/23/2006	HM .		
IEEE	9/23/2006	НМ		
Palm Inventors DB	9/23/2006	НМ		
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